



5N50-P

Power MOSFET

5A, 500V N-CHANNEL POWER MOSFET

DESCRIPTION

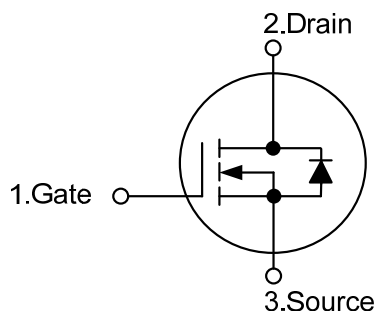
The UTC **5N50-P** is an N-channel power MOSFET adopting UTC's advanced technology to provide customers with DMOS, planar stripe technology. This technology is designed to meet the requirements of the minimum on-state resistance and perfect switching performance. It also can withstand high energy pulse in the avalanche and communication mode.

The UTC **5N50-P** can be used in applications, such as active power factor correction, high efficiency switched mode power supplies, electronic lamp ballasts based on half bridge topology.

FEATURES

- * $R_{DS(ON)} < 1.6\Omega$ @ $V_{GS} = 10V$, $I_D = 2.5A$
- * 100% avalanche tested
- * High switching speed

SYMBOL

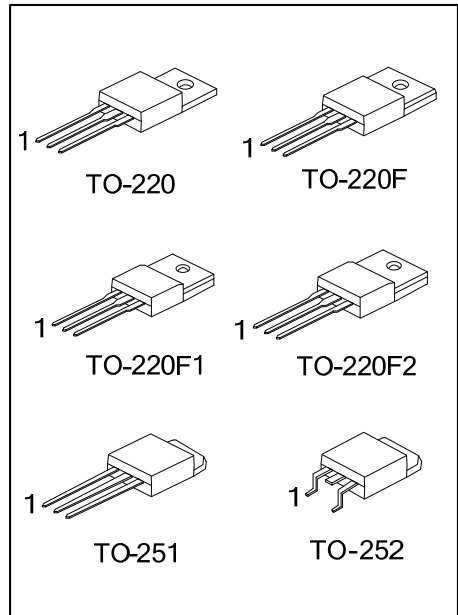


ORDERING INFORMATION

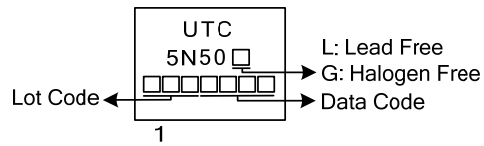
| Ordering Number | | Package | Pin Assignment | | | Packing |
|-----------------|--------------|----------|----------------|---|---|-----------|
| Lead Free | Halogen Free | | 1 | 2 | 3 | |
| 5N50L-TA3-T | 5N50G-TA3-T | TO-220 | G | D | S | Tube |
| 5N50L-TF3-T | 5N50G-TF3-T | TO-220F | G | D | S | Tube |
| 5N50L-TF1-T | 5N50G-TF1-T | TO-220F1 | G | D | S | Tube |
| 5N50L-TF2-T | 5N50G-TF2-T | TO-220F2 | G | D | S | Tube |
| 5N50L-TM3-R | 5N50G-TM3-R | TO-251 | G | D | S | Tape Reel |
| 5N50L-TN3-R | 5N50G-TN3-R | TO-252 | G | D | S | Tape Reel |

Note: Pin Assignment: G: Gate D: Drain S: Source

| | | |
|--|-------------------|---|
| | (1) Packing Type | (1) R: Tape Reel, T: Tube |
| | (2) Package Type | (2) TA3: TO-220, TF3: TO-220F, TF1: TO-220F1 TF2: TO-220F2, TM3: TO-251, TN3: TO-252 |
| | (3) Green Package | (3) L: Lead Free, G: Halogen Free and Lead Free |



■ MARKING



■ ABSOLUTE MAXIMUM RATINGS ($T_C=25^{\circ}\text{C}$, unless otherwise specified)

| PARAMETER | | SYMBOL | RATINGS | UNIT |
|--------------------------------------|------------------------|-----------|----------|--------------------|
| Drain-Source Voltage | | V_{DSS} | 500 | V |
| Gate-Source Voltage | | V_{GSS} | ± 30 | V |
| Drain Current | Continuous | I_D | 5 | A |
| | Pulsed (Note 2) | I_{DM} | 20 | A |
| Avalanche Current (Note 2) | | I_{AR} | 5 | A |
| Avalanche Energy | Single Pulsed (Note 3) | E_{AS} | 190 | mJ |
| | Repetitive (Note 2) | E_{AR} | 7.3 | mJ |
| Peak Diode Recovery dv/dt (Note 4) | | dv/dt | 4.5 | V/ns |
| Power Dissipation | TO-220 | P_D | 125 | W |
| | TO-220F/TO-220F1 | | 38 | W |
| | TO-220F2 | | | |
| | TO-251/TO-252 | | 54 | W |
| Junction Temperature | | T_J | +150 | $^{\circ}\text{C}$ |
| Storage Temperature | | T_{STG} | -55~+150 | $^{\circ}\text{C}$ |

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature

3. $L = 15.5\text{mH}$, $I_{AS} = 5\text{A}$, $V_{DD} = 50\text{V}$, $R_G = 25\Omega$, Starting $T_J = 25^{\circ}\text{C}$

4. $I_{SD} \leq 5\text{A}$, $di/dt \leq 200\text{A}/\mu\text{s}$, $V_{DD} \leq BV_{DSS}$, Starting $T_J = 25^{\circ}\text{C}$

■ THERMAL DATA

| PARAMETER | | SYMBOL | RATINGS | UNIT |
|---------------------|-------------------|---------------|---------|-----------------------------|
| Junction to Ambient | TO-220/TO-220F | θ_{JA} | 62.5 | $^{\circ}\text{C}/\text{W}$ |
| | TO-220F1/TO-220F2 | | | $^{\circ}\text{C}/\text{W}$ |
| | TO-251/TO-252 | | 110 | $^{\circ}\text{C}/\text{W}$ |
| Junction to Case | TO-220 | θ_{JC} | 1 | $^{\circ}\text{C}/\text{W}$ |
| | TO-220F/TO-220F1 | | 3.25 | $^{\circ}\text{C}/\text{W}$ |
| | TO-220F2 | | | |
| | TO-251/TO-252 | | 2.13 | $^{\circ}\text{C}/\text{W}$ |

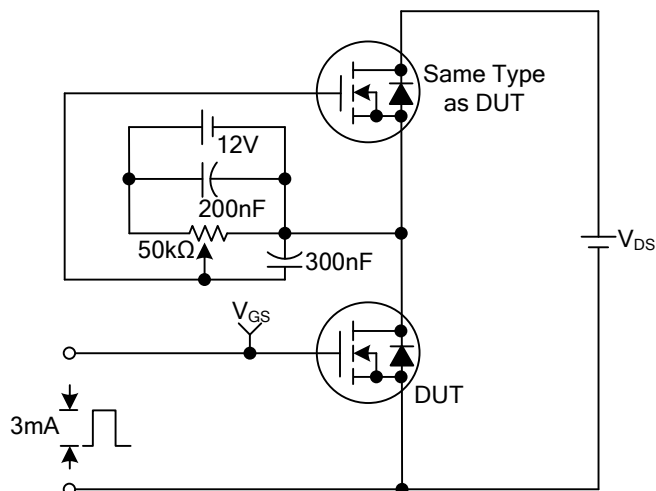
■ ELECTRICAL CHARACTERISTICS (T_C=25°C, unless otherwise specified)

| PARAMETER | | SYMBOL | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---------|-------------------------------------|--|-----|-----|------|------|
| OFF CHARACTERISTICS | | | | | | | |
| Drain-Source Breakdown Voltage | | BV _{DSS} | I _D =250μA, V _{GS} =0V | 500 | | | V |
| Breakdown Voltage Temperature Coefficient | | ΔBV _{DSS} /ΔT _J | Reference to 25°C, I _D =250μA | | 0.5 | | V/°C |
| Drain-Source Leakage Current | | I _{DSS} | V _{DS} =500V, V _{GS} =0V | | | 1 | μA |
| | | | V _{DS} =400V, T _C =125°C | | | 10 | |
| Gate- Source Leakage Current | Forward | I _{GSS} | V _{GS} =30V, V _{DS} =0V | | | 100 | nA |
| | Reverse | | V _{GS} =-30V, V _{DS} =0V | | | -100 | nA |
| ON CHARACTERISTICS | | | | | | | |
| Gate Threshold Voltage | | V _{GS(TH)} | V _{DS} =V _{GS} , I _D =250μA | 2.0 | | 4.0 | V |
| Static Drain-Source On-State Resistance | | R _{DS(ON)} | V _{GS} =10V, I _D =2.5A | | 1.2 | 1.6 | Ω |
| DYNAMIC PARAMETERS | | | | | | | |
| Input Capacitance | | C _{ISS} | V _{GS} =0V, V _{DS} =25V, f=1.0MHz | | 580 | | pF |
| Output Capacitance | | C _{OSS} | | | 66 | | pF |
| Reverse Transfer Capacitance | | C _{RSS} | | | 10 | | pF |
| SWITCHING PARAMETERS | | | | | | | |
| Turn-ON Delay Time | | t _{D(ON)} | V _{DD} =30V, I _D =0.5A, R _G =25Ω (Note 1, 2) | | 30 | | ns |
| Rise Time | | t _R | | | 80 | | ns |
| Turn-OFF Delay Time | | t _{D(OFF)} | | | 110 | | ns |
| Fall-Time | | t _F | | | 90 | | ns |
| Total Gate Charge | | Q _G | V _{GS} =10V, V _{DS} =50V, I _D =1.3A, I _D =100μA (Note 1, 2) | | 18 | 24 | nC |
| Gate to Source Charge | | Q _{GS} | | | 2.2 | | nC |
| Gate to Drain Charge | | Q _{GD} | | | 9.7 | | nC |
| SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS | | | | | | | |
| Maximum Continuous Drain-Source Diode Forward Current | | I _S | | | | 5 | A |
| Maximum Pulsed Drain-Source Diode Forward Current | | I _{SM} | | | | 20 | A |
| Drain-Source Diode Forward Voltage | | V _{SD} | I _S =5A, V _{GS} =0V | | | 1.4 | V |
| Reverse Recovery Time | | t _{rr} | I _S =5A, V _{GS} =0V, | | 263 | | ns |
| Reverse Recovery Charge | | Q _{RR} | dl _F /dt=100A/μs (Note 1) | | 1.9 | | μC |

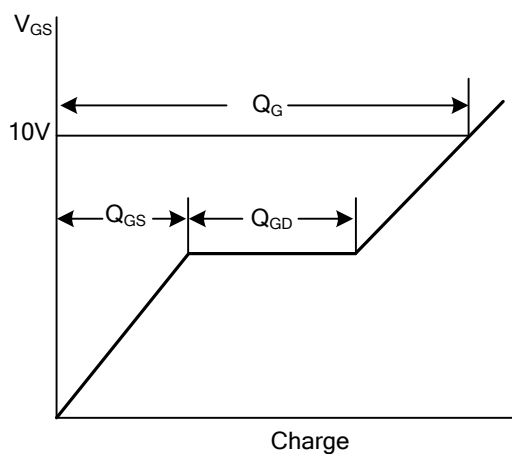
Notes: 1. Pulse Test: Pulse width ≤ 300μs, Duty cycle ≤ 2%

2. Essentially independent of operating temperature

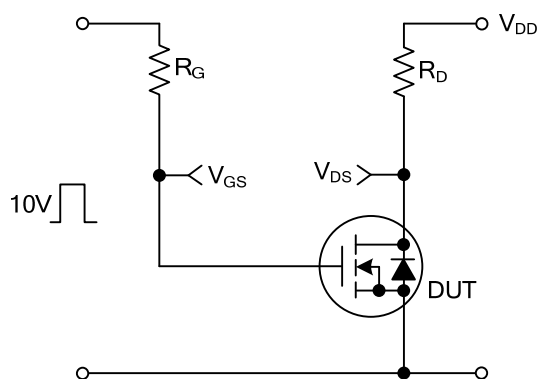
■ TEST CIRCUITS AND WAVEFORMS



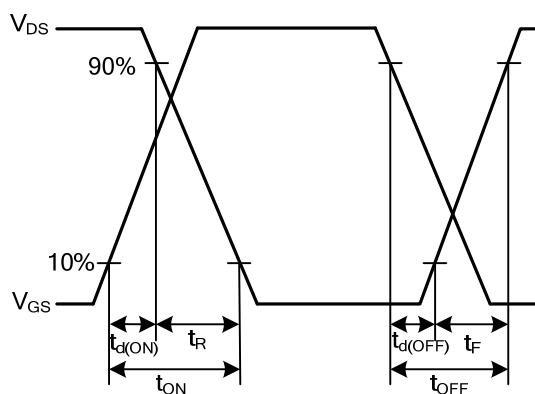
Gate Charge Test Circuit



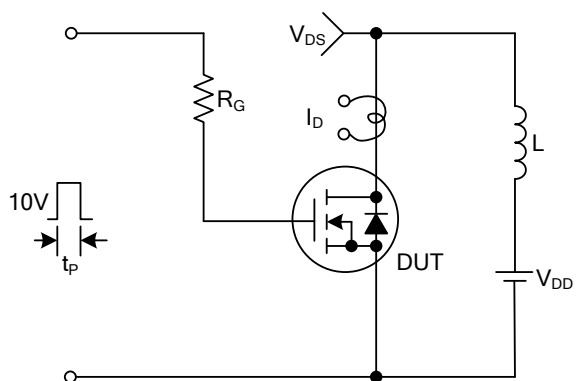
Gate Charge Waveforms



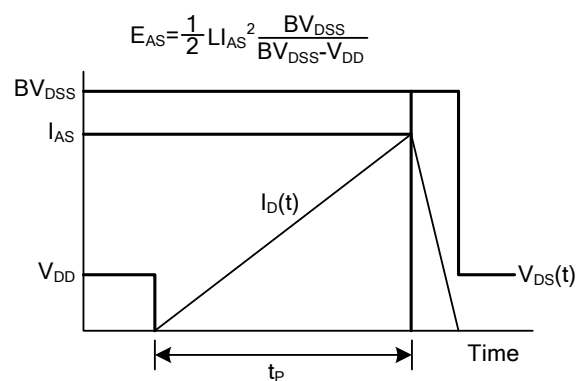
Resistive Switching Test Circuit



Resistive Switching Waveforms



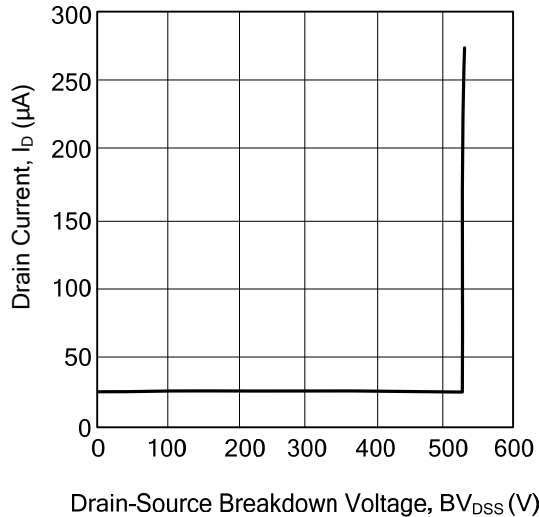
Unclamped Inductive Switching Test Circuit



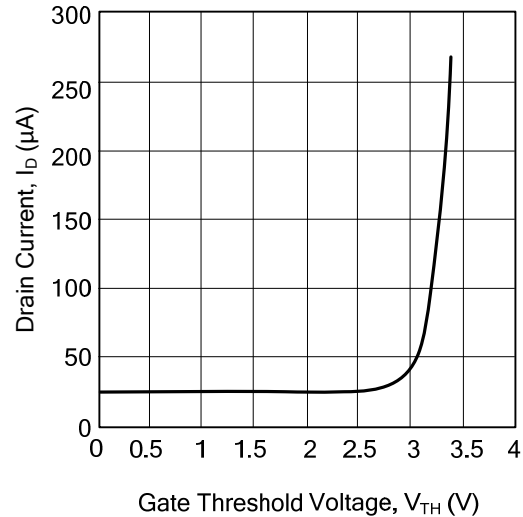
Unclamped Inductive Switching Waveforms

■ TYPICAL CHARACTERISTICS

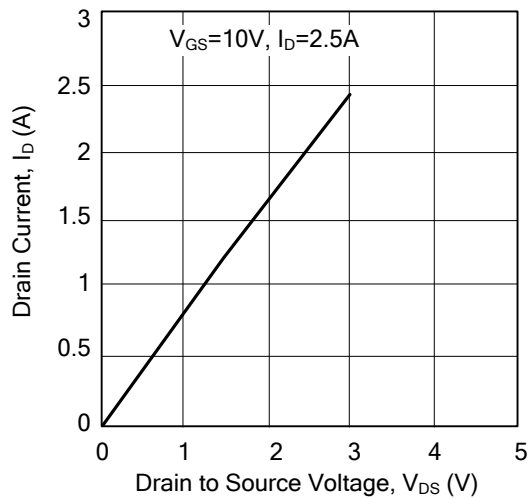
Drain Current vs. Drain-Source Breakdown Voltage



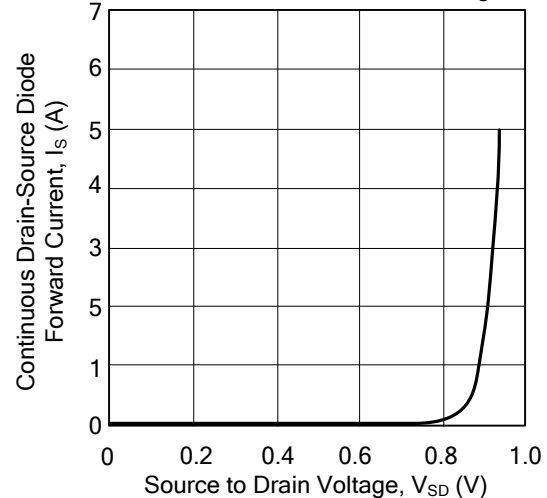
Drain Current vs. Gate Threshold Voltage



Drain-Source On-State Resistance Characteristics



Continuous Drain-Source Diode Forward Current vs. Source to Drain Voltage



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